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Notice of Allowability	Application No.	lication No. Applicant(s)		
	10/573,083 Examiner	VRANKEN ET AL. Art Unit		
	David Ton	2117		
The MAILING DATE of this communication apperature All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this or other appropriate communica IGHTS. This application is subje-	application. If not include tion will be mailed in due	ed course. THIS	
1. This communication is responsive to <u>Amendment filed on the second se</u>	<u>06/28/2007</u> .			
2. X The allowed claim(s) is/are 1-9.				
3. ☐ Acknowledgment is made of a claim for foreign priority unall All b) ☐ Some* c) ☐ None of the: 1. ☐ Certified copies of the priority documents have 2. ☐ Certified copies of the priority documents have 3. ☐ Copies of the certified copies of the priority documents have 1. ☐ Copies of the certified copies of the priority documents have 2. ☐ Copies of the certified copies of the priority documents have 3. ☐ Copies of the certified copies of the priority documents have 2. ☐ Copies of the certified copies of the priority documents have 3. ☐ Copies of the certified copies of the priority documents have 2. ☐ Certified copies of the priority documents have 3. ☐ Certified copies of the priority documents have 3. ☐ Certified copies of the priority documents have 4. ☐ ASUBSTITUTE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 4. ☐ A SUBSTITUTE OATH OR DECLARATION must be subminated by the ASUBSTITUTE OATH OR DECLARATION (PTO-152) which give 5. ☐ CORRECTED DRAWINGS (as "replacement sheets") must (a) ☐ including changes required by the Notice of Draftspers 1) ☐ hereto or 2) ☐ to Paper No./Mail Date (b) ☐ including changes required by the attached Examiner' Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in the certified copies of the priority documents have a certified copies of th	e been received. e been received in Application Note been received in Application Note been received in the of this communication to file a replication. Interest Note the attached EXAMIN es reason(s) why the oath or declet be submitted. Son's Patent Drawing Review (Pins Amendment / Comment or in the drawing she header according to 37 CFR 1.1	his national stage applicate this national stage applicate ply complying with the recent of a swings in the front (not the 21(d).	quirements OTICE OF back) of	
attached Examiner's comment regarding REQUIREMENT Attachment(s)	FOR THE DEPOSIT OF BIOLOG	BICAL MATERIAL.	iote the	
 Notice of References Cited (PTO-892) D Notice of Draftperson's Patent Drawing Review (PTO-948) 	5. Notice of Informa			
3. ☐ Information Disclosure Statements (PTO/SB/08),	Paper No./Mail	 6. ☐ Interview Summary (PTO-413), Paper No./Mail Date		
Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. 🛭 Examiner's State	ement of Reasons for Allo	wance	
	9. Other			
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Art Unit: 2117

- 1. Applicants Amendment filed on 06/28/2007 has been reviewed.
- 2. Claims 1-9 are allowed.
- 3. The following is an Examiner's Statement of Reasons for Allowance:
- a). The prior art of record teaches the claimed invention substantially, but it fails to teach or suggest singly or in combination an apparatus and method for testing an integrated circuit wherein the apparatus comprising a compactor to compress test responses from a circuit-under-test that is part of an integrated circuit and a masking circuitry coupled between the circuit-under-test and the compactor for masking one or more of the test responses from the circuit-under-test, characterized in that the masking circuitry further comprises decompression circuitry for receiving compressed mask data from the apparatus and providing decompressed mask data to the mask circuitry as set forth in independent claim 1 and 8.
- b). The prior art of record teaches the claimed invention substantially, but it fails to teach or suggest singly or in combination a method for computing compressed mask data for use in masking test data from an integrated circuit, characterized in that it comprises the steps of generating a set of equations associated with the mask data; and solving the equations to obtain compressed mask data as set forth in independent claim 9.
- 4. Any comments considered necessary by applicant must be submitted no later than the payment of the Issue Fee and, to avoid processing delays, should preferably

Page 3

Application/Control Number: 10/573,083

Art Unit: 2117

accompany the Issue Fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance".

5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to David Ton whose telephone number is (571) 272-3828. The examiner can normally be reached on M-F from 8:00 - 5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jacques Louis-Jacques can be reached on (571) 272-6962. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

David Ton
Primary Examiner

Art Unit 2117